

# WEPAB330 A multirange Low Noise Transimpedance Amplifier for Sirius Beamlines

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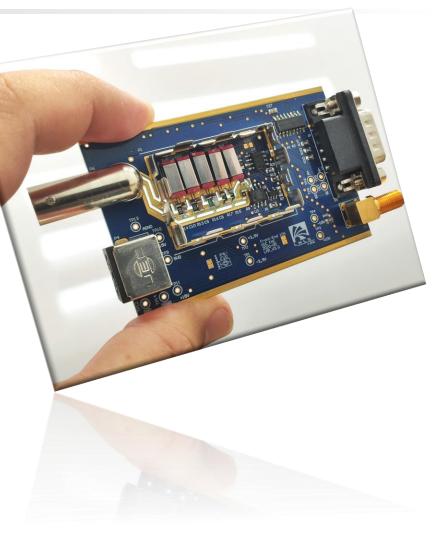
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# Low current measurements at Sirius beamlines

6485

**Keithley** 

000000000

**U\$2300** 

**DDPCA-300** 

**FEMTO** 

U\$ 2800

9103

RBD

**U\$ 2000** 

**SR570** 

SRS

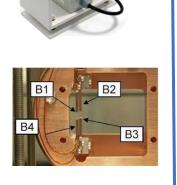
U\$ 3000

8 C .....

- Photodiodes;
- Ionization Chambers;
- Slits;
- Electron collectors;
- Beam position monitors
  - ✓ Blades, Wires, Diamond



Range: Picoampere to Milliampere

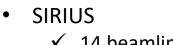






- ✓ 18 beamlines
  - ✓ ~ 30 devices

UVX (our old machine)



✓ 14 beamlines (Phase 1A and 1B)

✓ ~200 devices

Decision for in-house development: A Multirange Low Noise Transimpedance Amplifiers



Standard Acquisition Hardware







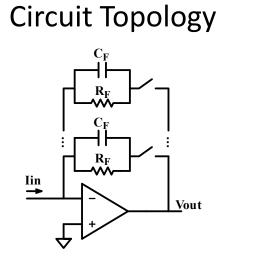
# Specification and circuit implementation

#### Benchmark: SR570

U\$ 3.000

#### **In-house specification**

Parameters	Value
Input Channels	1
Input Connectors	BNC or TRIAX
Full-scale ranges	500pA to 7.3mA (5 SCALES)
Input Current Polarity	Bipolar
Output Voltage	±5V
Bandwidth	10 Hz at 100pA/V scale 1 kHz for Other scales
RMS Noise	10 fA/VHz (max) @100pA/V, 1Hz
Size	80x54x23mm
Gain Error	10% (max) @100pA/V scale
Drift	250ppm @100pA/V scale
Accuracy	±10% @100pA/V scale



#### **Common error sources**

- Surface leakage
- Triboelectric effect
- EMI e RFI (effective shielding needed)
- Electrostatic coupling
- Temperature variation
- Humidity
- Dirty

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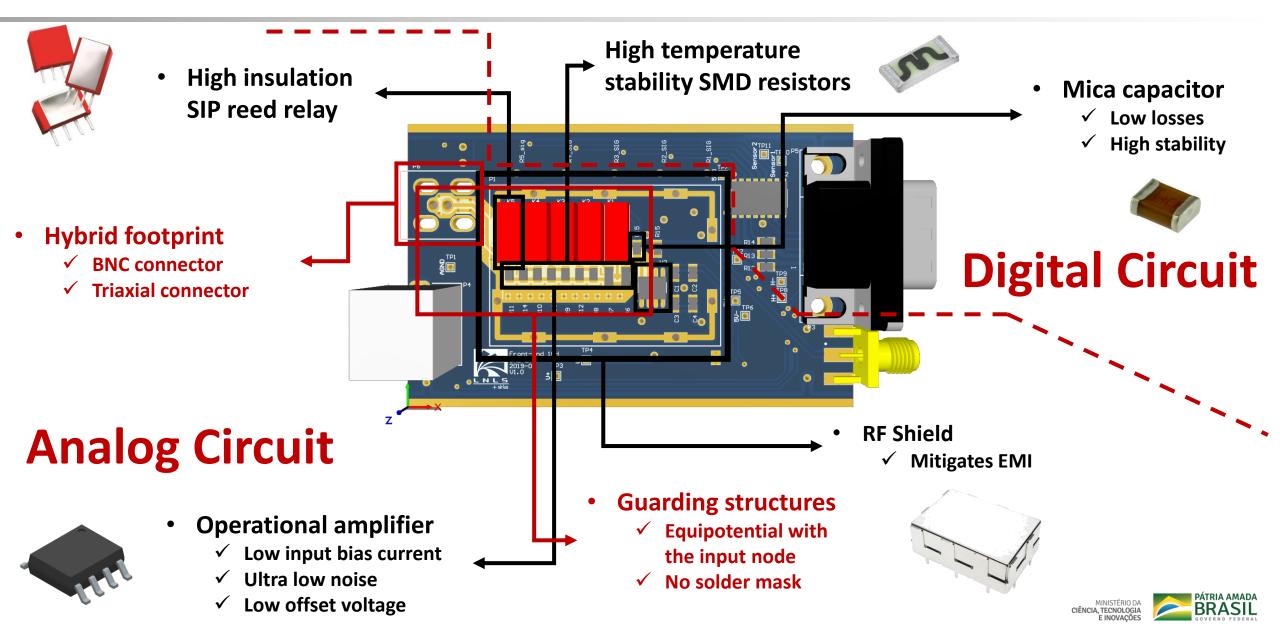
• Cosmic rays (<pA Range)

#### Theoretical analysis $V_{out} = -R_F I_{in}$ $f_{cutoff} = \frac{1}{2\pi R_F C_F}$ $v_{total_n} = \sqrt{v_{v_n}^2 + v_{i_n}^2 + v_{R_{F_n}}^2}$ $v_{johnson} = \sqrt{4k_B T R_F \Delta f}$ **OPEN-LOOP GAIN** GAIN (dB) IF C<sub>F</sub> = 0fF SIGNAL BANDWIDTH **CLOSED-LOOP BANDWIDTH** NG<sub>2</sub> NOISE GAIN NG<sub>1</sub> FREQUENCY (Hz) fugc



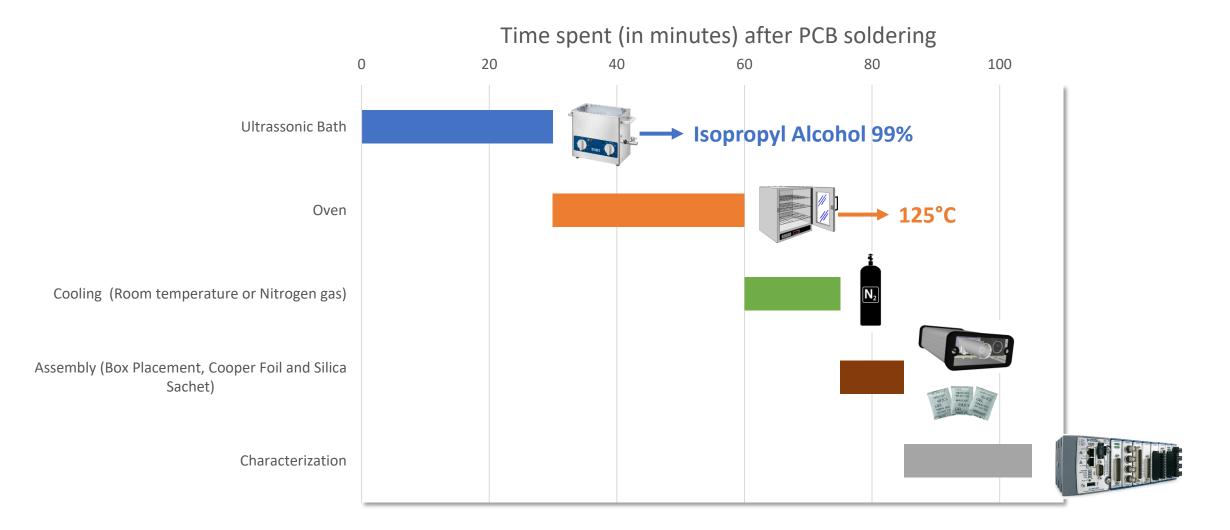


# Component selection and hardware design





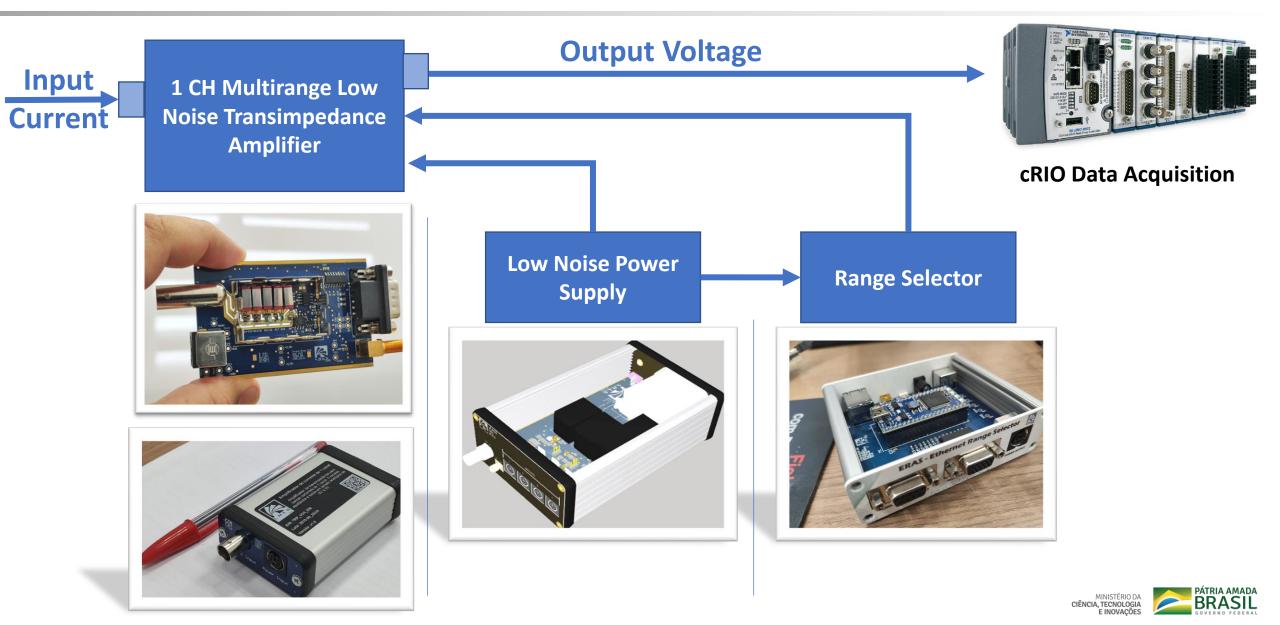
## **Cleaning process**





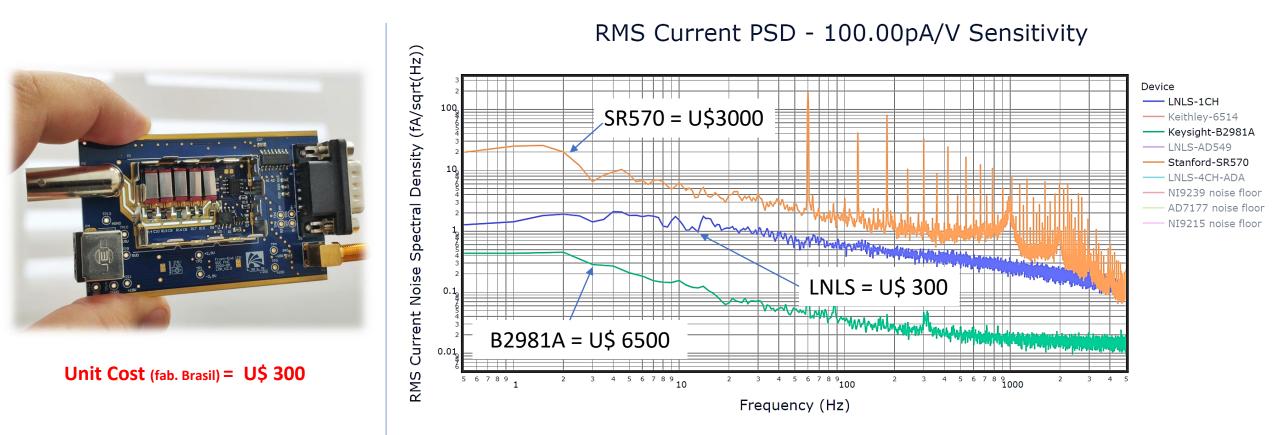


## **Installation Diagram**





## **Results: Noise Comparison**







# **Conclusions**

- The first units were developed successfully. For low bandwidth applications, the noise performance is comparable to expansive well-known commercial bench equipment;
- A number of error sources can have serious impacts on low current measurements. The right component choice and all the strategies adopted to make a proper guarding, shielding and PCB layout showed to be effective to reduce static and dynamic errors;
- The cleaning process showed to be an indispensable process, specially for the most sensible range: the offset voltage after the cleaning process, on average, reduced three orders of magnitude;
- For the first fourteen beamlines, we have produced around 75 units. Due to increase number of devices for low current monitoring, the in-house development is more cost-effective solution.
- Besides the low noise amplifier, we also have developed an ultra low noise power supply and an ethernet range selector to the fully integration on the beamline's control system;

### **Future plans**

• To fulfill the Sirius beamlines applications other devices must be developed in a near future, such as a 4-channel digital picoammeter (with integrated ADCs and ethernet interface) and a single scale amplifier with a high dynamic range ;



# Thank you for your attention!



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